# Status and progress of TPC module and prototype R&D in IHEP

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# Outline

- Physics requirements
- Status of TPC module R&D
- Status of TPC prototype R&D
- Summary

## **Technical challenges for TPC**

#### **Ion Back Flow and Distortion :**

- ~100 μm position resolution in rφ
- Distortions by the primary ions at CEPC are negligible
- More than 10000 discs co-exist and distorted the path of the seed electrons
- The ions have to be cleared during the ~us period continuously
- Continuous device for the ions
- Long working time

#### **Calibration and alignment:**

- Systematics precision (<20 μm internal)</li>
- Geometry and mechanic of chamber
- Modules and readout pads
- Track distortions due to space charge effects of positive ions



#### Evaluation of track distortions

500

Drift Length [mm]

700

r/mm

400

500

600



Ions backflow in drift volume for distortion

# Options of technical solution

#### **Continuous IBF module:**

- Gating device may be used for Higgs run
- Open and close time of gating device for ions: ~ µs-ms
- No Gating device option for Z-pole run
- Continuous Ion Back Flow due to the continuous beam structure
- Low discharge and spark possibility

#### Laser calibration system:

- Laser calibration system for Z-pole run
- The ionization in the gas volume along the laser path occurs via two photon absorption by organic impurities
- Calibrated drift velocity, gain uniformity, ions back in chamber
- Calibration of the distortion
- Nd:YAG laser device@266nm



#### Continuous IBF prototype and IBF $\times$ Gain



TPC prototype integrated with laser system

# Investigation of IBF study with module

#### Test of the new module

- **Test with GEM-MM module** 
  - New assembled module
  - □ Active area: 100mm × 100mm
  - **A** X-tube ray and 55Fe source
  - **Bulk-Micromegas from Saclay**
  - Standard GEM from CERN
  - Additional UV light device
  - Avalanche gap of MM:128μm
  - □ Transfer gap: 2mm
  - Drift length:2mm~200mm
  - Mesh: 400LPI





#### Micromegas(Saclay)

#### **GEM(CERN)**



Cathode with mesh

**GEM-MM** Detector

#### **Electrometer/High Resistance Meter**

#### Keithley 6517B

Electrometer/High Resistance Meter, 100aA - 20mA, 10μV - 200V, 100Ω - 10PΩ

Brand:	Keithley
Model No:	6517B



#### Product Features:

- Measures resistances up to 10180
- 10aA (10×10-18A) current measurement resolution
- Less than 3fA input bias current
- · 6 1/2-digit high accuracy measurement mode
- Less than 20µV burden voltage on the lowest current ranges
- Voltage measurements up to 200V with >200TO input impedance
- Built-in +/-1000V voltage source
- · Unique alternating polarity voltage sourcing and measurement method for high resistance measurements
- Built-in test sequences for four different device characterization tests, surface and volume resistivity, surface insulation resistance, and voltage sweeping
- Optional plug-in scanner cards for testing up to 10 devices or material samples with one test setup





## Measuremnt of GEM-MM module

# Test with GEM-MM module

- Keithley Electrometers for Ultra-Low Current Measurements: pA~mA
- Keithley: 6517B
- Test of cathode of the module
- Test of readout anode of the module
- Labview interface of the low current to make the record file automatically

$$IBF = \frac{I_C - I_P}{I_A}$$

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Labview interface of the current with Keithley

### **GEM-MM** module



High voltage diagram of the detector module





### Primary electrons current



- □ No operation voltage of the GEM-MM detector
- □ Just test current of the primary electrons (~pA)

Ic and Ia



**GEM** with operation voltage

□ MM with operation voltage

#### **IBF** and Gain



Fig. 4: (color online) Gas gain and IBF versus (a) GEM voltage, micromesh  $V_{mesh} = 420$  V and (b) micromesh voltage,  $V_{gem} = 340$  V.  $E_d = 250$  V/cm,  $E_t = 500$  V/cm.

# Status of TPC prototype R&D

#### Parameters of the TPC prototype

- To aim that the small TPC prototype for the estimation of the distortion due to the IBF, and the study of related physics parameters
- To mimic the bunch structure & the ions distortion with UV light and laser split beam

#### Main parameters

- Drift length: 510mm
- □ Readout active area: 200mm×200mm
- **Integrated the laser and UV lamp device**
- □ Wavelength of laser: 266nm
- **GEMs/Micromegas as the readout**
- Materials: Non-magnetic material (Stainless steel, Aluminum)

## Why UV light study

- □ IBF measurement methods
  - **55Fe radioactive source**
  - **X** tube machine
  - **Synchrotron radiation**
  - **UV** light by the photoelectric effect





Photoelectric effect



#### UV test of the new module

- □ UV lamp measurement
  - New designed and assembled UV test chamber
  - □ Active area: 100mm × 100mm
  - **Deuterium lamp and aluminum film**
  - Principle of photoelectric effect
  - □ Wave length: 160nm~400nm
  - Fused silica: 99% light trans.@266nm
  - Improve the field cage in drift length



Deuterium lamp X2D2 lamp







Diagram of the UV test with new module



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### Signal of the laser with $\Phi 1 mm$ @266nm



Signal of the laser with  $\Phi$ 1mm@Charge sensitive AMP/12mV/fC



Area of laser beam in detector

## **Divide and reflection** mirrors

- Laser wave for the divide and reflection mirrors: 266nm
- Number of the divide trackers: 6 Optimization
- Stainless steel support integrated the laser mirrors
- **Reflection efficiency:** 
  - >99%@266nm
- **Reflection position accuracy** 
  - 1/30 degree







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Aluminum board integrated the laser system

### Design of the prototype with laser (Final version)



□ Support platform: 1200mm×1500mm (all size as the actual geometry)

- **TPC** barrel mount and re-mount with the Auxiliary brackets
- **Readout board (Done), Laser mirror (Done), PCB board (Done)**

## **Brief history**





С	Concept study		Smaller prototype		Large prototype		Common	module
2006~2010	2012	2013	2014	2015	2016	2017	2018	2019
Tsinghua starting for prototypeIHEP startPCB readout designHybrid corDr. Li boDr. HuironProf. Yulan LiProf. Yuan		P starting for p id concept for luirong Qi Yuanning Gao	orototype IBF	We are in h Hybrid pro Calibration CDR for C	nere ototype starting n using laser EPC			

# Thanks.